

# **Si6435DQ**

# 30V P-Channel PowerTrench® MOSFET

### **General Description**

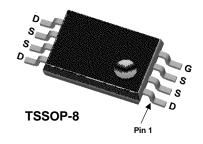
This P-Channel MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications requiring a wide range of gate drive voltage ratings (4.5V-20V).

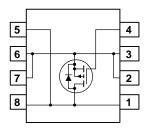
### **Applications**

- · Battery protection
- DC/DC conversion
- · Power management
- Load switch

#### **Features**

- -4.5 A, -30 V  $R_{DS(ON)} = 40 \text{ m}\Omega$  @  $V_{GS} = -10 \text{ V}$  $R_{DS(ON)} = 70 \text{ m}\Omega$  @  $V_{GS} = -4.5 \text{ V}$
- $\bullet~$  Extended  $V_{\text{GSS}}$  range (±20V) for battery applications
- High performance trench technology for extremely low  $R_{\mbox{\scriptsize DS(ON)}}$
- Low profile TSSOP-8 package





### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		-30	V
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1)	-4.5	А
	- Pulsed		-30	
P <sub>D</sub>	Power Dissipation	(Note 1a)	1.3	W
		(Note 1b)	0.6	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		−55 to +150	°C

## **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	87	°C/W
		(Note 1b)	114	

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity
6435 Si6435D0		13"	16mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			ı	ı	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-30			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}$ , Referenced to 25°C		-23		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V},  V_{GS} = 0 \text{ V}$			-1	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V},  V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_{D} = -250 \ \mu A$	-1	-1.7	-3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}$ , Referenced to 25°C		5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$\begin{split} V_{GS} &= -10 \text{ V},  I_D = -4.5 \text{ A} \\ V_{GS} &= -4.5 \text{ V},  I_D = -3.4 \text{ A} \\ V_{GS} &= -10 \text{ V}, I_D = -4.5 \text{A}, T_J = 125^{\circ}\text{C} \end{split}$		27 42 38	40 70 60	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -10 \text{ V},  V_{DS} = -5 \text{ V}$	-30			Α
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = -15 \text{ V},  I_{D} = -4.5 \text{ A}$		12		S
Dynamic	Characteristics		•		•	
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -15 \text{ V},  V_{GS} = 0 \text{ V},$		854		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		215		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			112		pF
Switchir	ng Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -15 \text{ V},  I_{D} = -1 \text{ A},$		9	20	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = -10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		14	20	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			29	55	ns
t <sub>f</sub>	Turn-Off Fall Time			15	25	ns
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{F} = -1.25 \text{ A},$ $dI_{F}/dt = 100\text{A}/\mu\text{s}$		19	80	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = -15 \text{ V},  I_{D} = -4.5 \text{ A},$		15	35	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -10 \text{ V}$		2.4		nC
$Q_{gd}$	Gate-Drain Charge			3		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
I <sub>S</sub>	Maximum Continuous Drain-Source				-1.25	А
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = -1.25 \text{ A (Note 2)}$		-0.75	-1.2	V

<sup>1.</sup> R<sub>6JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $\rm\,R_{\theta JC}$  is guaranteed by design while  $\rm\,R_{\theta CA}$  is determined by the user's board design.

a) R $_{\theta JA}$  is 87 °C/W (steady state) when mounted on a 1 inch² copper pad on FR-4. b) R $_{\theta JA}$  is 114 °C/W (steady state) when mounted on a minimum copper pad on FR-4.

<sup>2.</sup> Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%

# **Typical Characteristics**

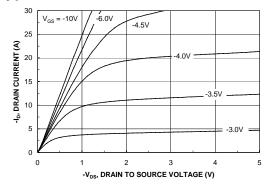


Figure 1. On-Region Characteristics.

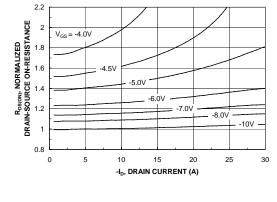


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

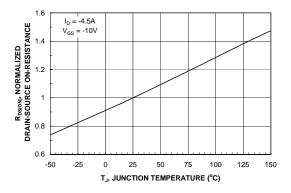


Figure 3. On-Resistance Variation with Temperature.

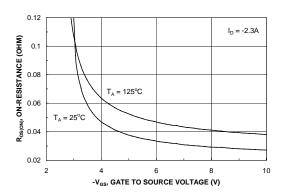


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

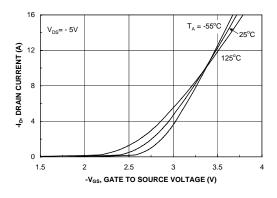


Figure 5. Transfer Characteristics.

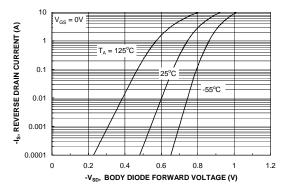


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics**

100

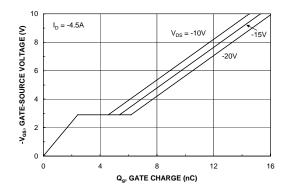
10

0.1

0.01

0.1

-I<sub>D</sub>, DRAIN CURRENT (A)



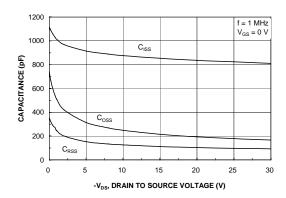


Figure 7. Gate Charge Characteristics.

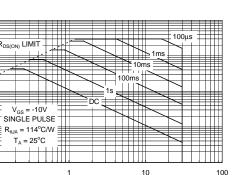


Figure 8. Capacitance Characteristics.

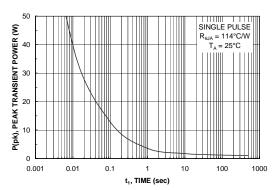


Figure 9. Maximum Safe Operating Area.

-V<sub>DS</sub>, DRAIN-SOURCE VOLTAGE (V)



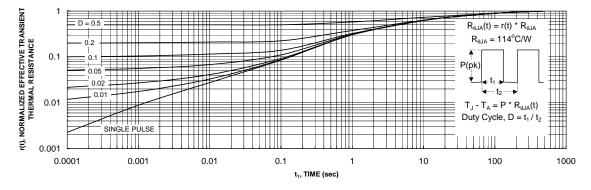


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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Rev. H4